

<b>Notice of References Cited</b>	Application/Control No. 10/064,560	Applicant(s)/Patent Under Reexamination WU, TSUNG-HSIEN	
	Examiner DuyVu n Deo	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0104319	06-2003	Lin et al.	430/313
	B	US-2003/0039893	02-2003	Farnsworth et al.	430/5
	C	US-6,134,008	10-2000	Nakao, Shuji	356/508
	D	US-5,610,754	03-1997	Gheen et al.	359/210
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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